

# INFORMATION DISCLOSURE CITATION

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Applicant Marc J.R. LEBLANS et al.	
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FOREIGN PATENT DOCUMENTS						
	Document Number	Publication Date	Country	Class	Sub Class	Translation Yes or No
EJS	1401179	7/23/75	GB			
EJS	1545437	5/10/79	GB			
EJS	3328821 A1	2/28/85	DE			
EJS	3328821	2/28/95	DE (abstract)			
EJS	3446727 A1	7/3/86	DE			
EJS	3446727	7/3/86	DE (abstract)			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)	
EJS	H. Harms and H.M. Aus, "Comparison of Digital Focus Criteria for a TV Microscope System", Cytometry 5, pp. 236-241 (1984).
EJS	F. C.A. Groen, I. T. Young, and G. Ligthart, "A Comparison of Different Focus Functions for Use in Autofocus Algorithms", Cytometry 6, pp. 81-91 (1985).
EJS	L. Firestone, K. Cook, K. Culp, N. Talsania, and K. Preston, Jr., "Comparison of Autofocus Methods for Automated Microscopy", Cytometry 12, pp. 195-206 (1991).
EJS	J.H. Price and D.A. Gough, "Comparison of Phase-Contrast and Fluorescence Digital Autofocus for Scanning Microscopy", Cytometry 16, pp. 283-297 (1994).
EJS	M.A. Kujoory, B.H. Mayall and M.L. Mendelsohn, "Focus-Assist Device for a Flying-Spot Microscope", IEEE Transactions on Biomedical Engineering, Vol. 20(2), pp. 126-132 (1973).
EJS	<a href="http://www.ee.washington.edu/conselec/CE/kuhn/edmulti/cdhome.gif">Http://www.ee.washington.edu/conselec/CE/kuhn/edmulti/cdhome.gif</a> , "Memory and Storage", editors of Time Life Books (1990).
EJS	E.T. Johnson and L.J. Goforth, Metaphase Spread Detection and Focus Using Closed Circuit Television", Journal of Histochemistry and Cytochemistry, 22(7), pp. 536-545 (1974).

Examiner <i>EJS Speers</i>	Date Considered <i>7/26/02</i>
Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	
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